PHB/PHD/PHU108NQ03LT

N-channel TrenchMOS™ logic level FET

Rev. 03 — 18 April 2005 Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS™ technology.

1.2 Features

- Logic level threshold
- Lead-free construction
- Very low on-state resistance
- Low gate charge

1.3 Applications

- DC-to-DC converter
- Switch-mode power supplies

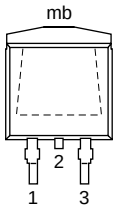
1.4 Quick reference data

- $V_{DS} \leq 25$ V
- $R_{DSon} \leq 6$ mΩ
- $I_D \leq 75$ A
- $Q_{gd} = 5.6$ nC (typ)

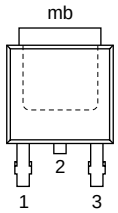
2. Pinning information

Table 1: Pinning

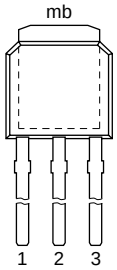
Pin	Description	Simplified outline	Symbol
1	gate (G)		
2	drain (D) [1]		
3	source (S)		
mb	mounting base; connected to drain		



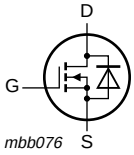
SOT404 (D2PAK)



SOT428 (DPAK)



SOT533 (IPAK)



[1] It is not possible to make a connection to pin 2 of the SOT404 and SOT428 packages.

PHILIPS

3. Ordering information

Table 2: Ordering information

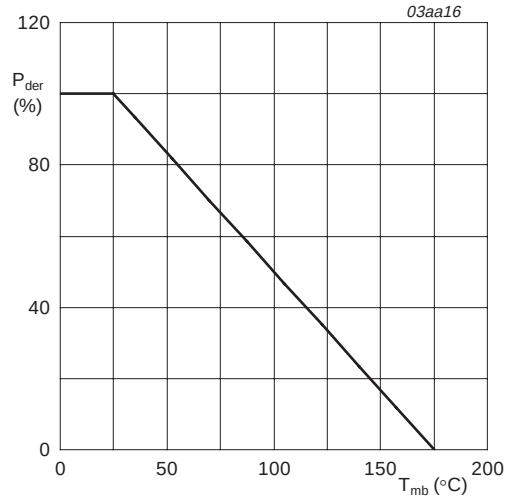
Type number	Package		
	Name	Description	Version
PHB108NQ03LT	D2PAK	plastic single-ended surface mounted package; 3 leads (one lead cropped)	SOT404
PHD108NQ03LT	DPAK	plastic single-ended surface mounted package; 3 leads (one lead cropped)	SOT428
PHU108NQ03LT	IPAK	plastic single-ended package; 3 leads (in-line)	SOT533

4. Limiting values

Table 3: Limiting values

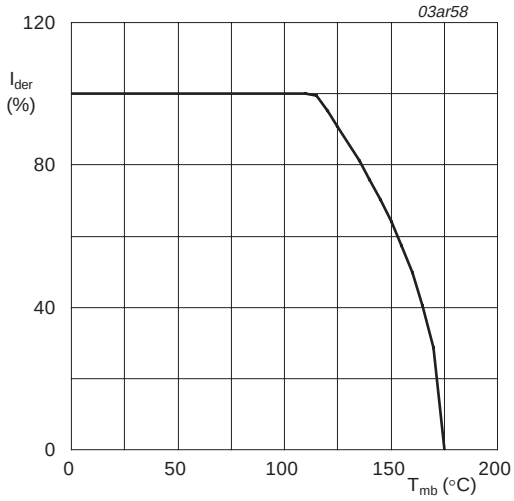
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	25 °C ≤ T_j ≤ 175 °C	-	25	V
V_{DGR}	drain-gate voltage (DC)	25 °C ≤ T_j ≤ 175 °C; R_{GS} = 20 kΩ	-	25	V
V_{GS}	gate-source voltage		-	±20	V
I_D	drain current (DC)	T_{mb} = 25 °C; V_{GS} = 5 V; Figure 2 and 3	-	75	A
		T_{mb} = 100 °C; V_{GS} = 5 V; Figure 2	-	75	A
I_{DM}	peak drain current	T_{mb} = 25 °C; pulsed; t_p ≤ 10 µs; Figure 3	-	240	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; Figure 1	-	187	W
T_{stg}	storage temperature		–55	+175	°C
T_j	junction temperature		–55	+175	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	T_{mb} = 25 °C	-	75	A
I_{SM}	peak source (diode forward) current	T_{mb} = 25 °C; pulsed; t_p ≤ 10 µs	-	240	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; I_D = 43 A; t_p = 0.25 ms; V_{DD} ≤ 25 V; R_{GS} = 50 Ω; V_{GS} = 10 V; starting at T_j = 25 °C	-	180	mJ



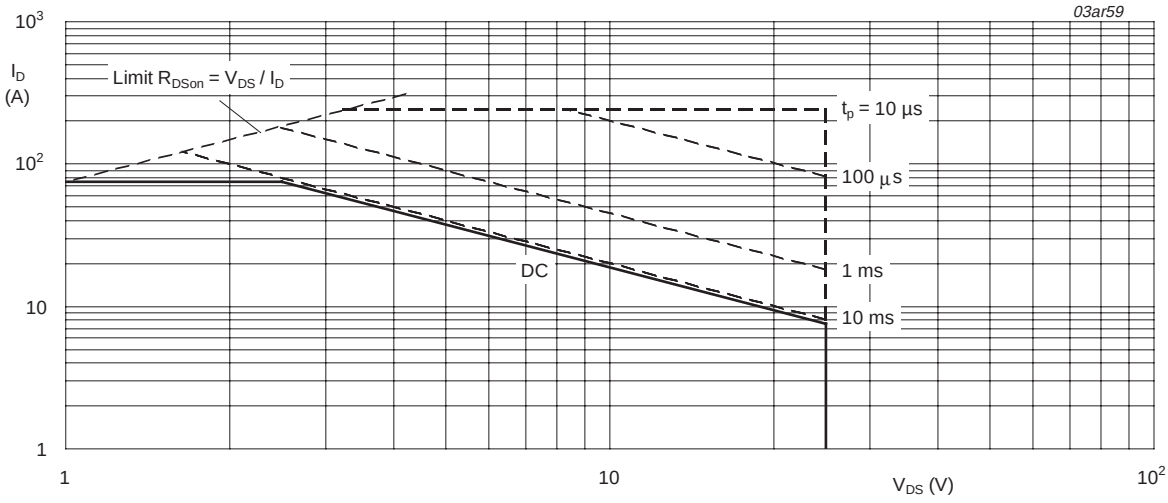
$$P_{der} = \frac{P_{tot}}{P_{tot(25\,^{\circ}C)}} \times 100\ \%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature



$$I_{der} = \frac{I_D}{I_{D(25\,^{\circ}C)}} \times 100\ \%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature



T_{mb} = 25 °C; I_{DM} is single pulse; V_{GS} = 5 V

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	0.8	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient					
	SOT404	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	50	-	K/W
	SOT428	mounted on a printed-circuit board; minimum footprint; vertical in still air	-	75	-	K/W
		mounted on a printed-circuit board; vertical in still air; SOT404 minimum footprint	-	50	-	K/W
	SOT533	vertical in free air	-	70	-	K/W

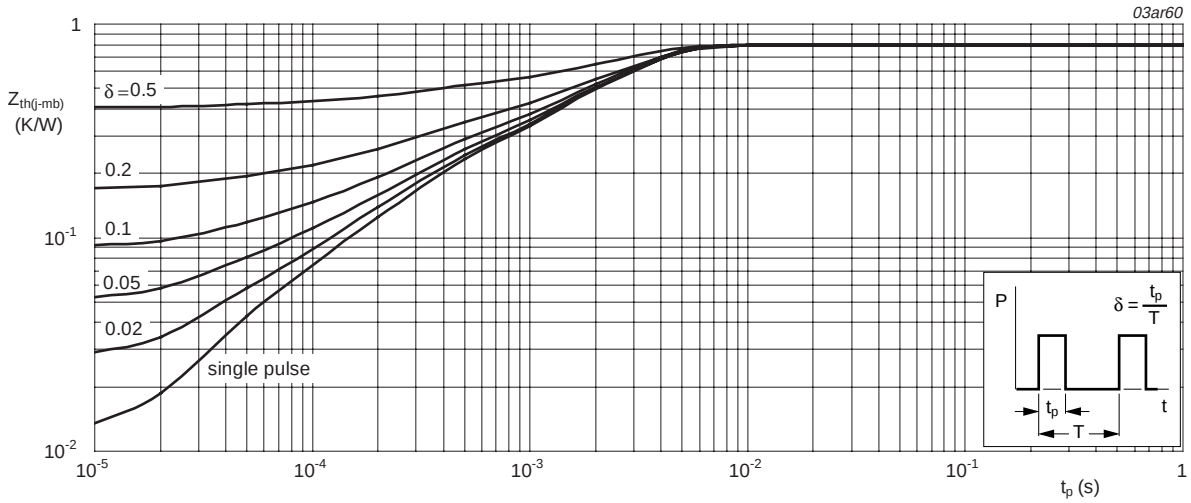


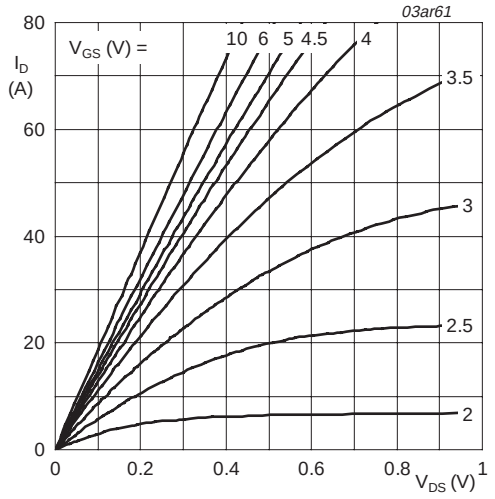
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 5: Characteristics

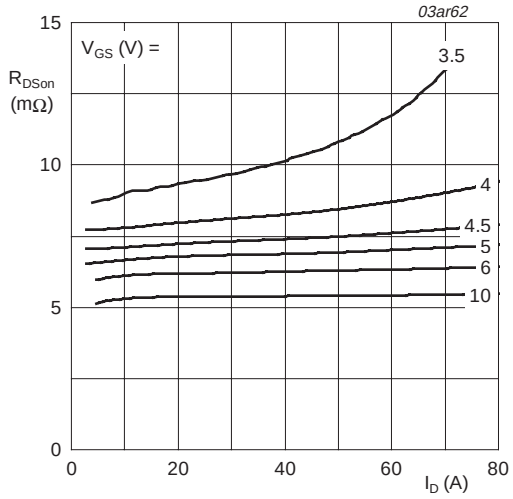
T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 250 µA; V_{GS} = 0 V				
		T_j = 25 °C	25	-	-	V
		T_j = –55 °C	22	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; Figure 9 and 10				
		T_j = 25 °C	1	1.5	2	V
		T_j = 175 °C	0.5	-	-	V
		T_j = –55 °C	-	-	2.2	V
I_{DSS}	drain-source leakage current	V_{DS} = 25 V; V_{GS} = 0 V				
		T_j = 25 °C	-	-	1	µA
		T_j = 175 °C	-	-	500	µA
R_G	gate resistance	f = 1 MHz	-	1.2	-	Ω
I_{GSS}	gate-source leakage current	V_{GS} = ±10 V; V_{DS} = 0 V	-	0.02	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 5 V; I_D = 25 A; Figure 6 and 8				
		T_j = 25 °C	-	6.7	7.5	mΩ
		T_j = 175 °C	-	12.1	13.5	mΩ
		V_{GS} = 10 V; I_D = 25 A; Figure 6 and 8	-	5.3	6	mΩ
Dynamic characteristics						
$Q_{g(tot)}$	total gate charge	I_D = 25 A; V_{DS} = 12 V; V_{GS} = 4.5 V; Figure 11 and 12	-	16.3	-	nC
Q_{gs}	gate-source charge		-	4	-	nC
Q_{gs1}	pre-$V_{GS(th)}$ gate-source charge		-	2.5	-	nC
Q_{gs2}	post-$V_{GS(th)}$ gate-source charge		-	1.5	-	nC
Q_{gd}	gate-drain (Miller) charge		-	5.6	-	nC
V_{plat}	plateau voltage		-	2.4	-	V
$Q_{g(tot)}$	total gate charge	I_D = 0 A; V_{DS} = 0 V; V_{GS} = 4.5 V	-	12.5	-	nC
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 12 V; f = 1 MHz; Figure 14	-	1375	-	pF
C_{oss}	output capacitance		-	640	-	pF
C_{rss}	reverse transfer capacitance		-	250	-	pF
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 0 V; f = 1 MHz	-	2120	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 12 V; R_L = 0.5 Ω; V_{GS} = 4.5 V; R_G = 5.6 Ω	-	15	-	ns
t_r	rise time		-	38	-	ns
$t_{d(off)}$	turn-off delay time		-	32	-	ns
t_f	fall time		-	25	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	I_S = 25 A; V_{GS} = 0 V; Figure 13	-	0.86	1.2	V
t_{rr}	reverse recovery time	I_S = 20 A; dI_S/dt = –100 A/µs; V_{GS} = 0 V; V_R = 25 V	-	34	-	ns
Q_r	recovered charge		-	21	-	nC



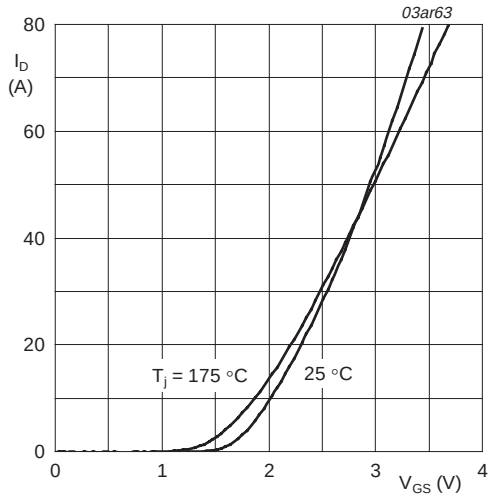
T_j = 25 °C

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



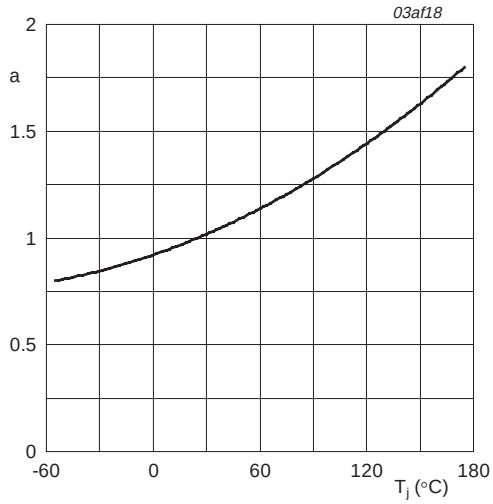
T_j = 25 °C

Fig 6. Drain-source on-state resistance as a function of drain current; typical values



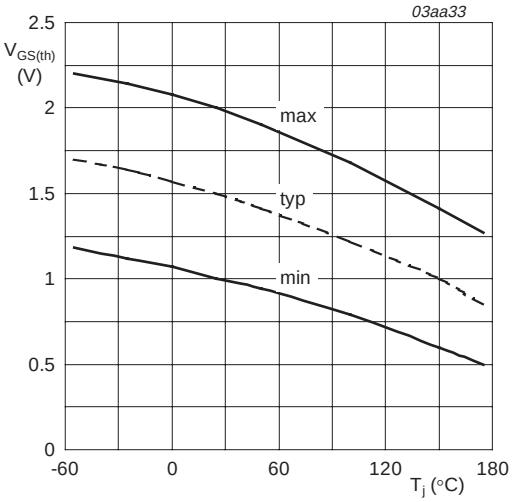
T_j = 25 °C and 175 °C; $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



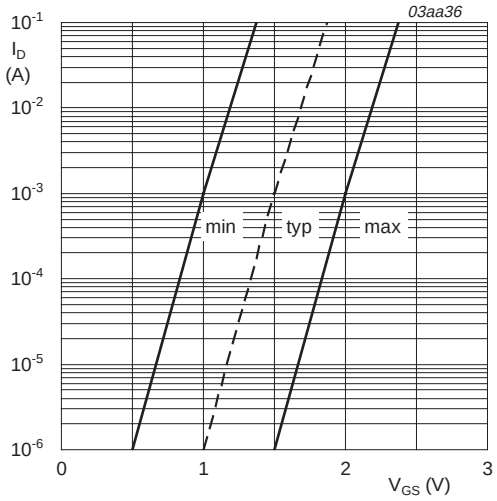
$$a = \frac{R_{DSon}}{R_{DSon(25\ ^\circ C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



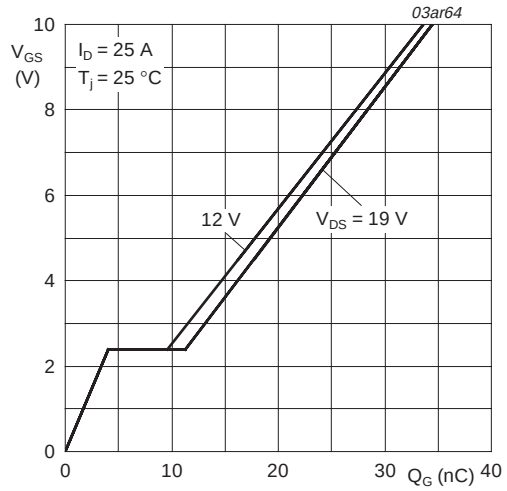
I_D = 1 mA; V_{DS} = V_{GS}

Fig 9. Gate-source threshold voltage as a function of junction temperature



T_j = 25 °C; V_{DS} = 5 V

Fig 10. Sub-threshold drain current as a function of gate-source voltage



I_D = 25 A; V_{DS} = 12 V and 19 V

Fig 11. Gate-source voltage as a function of gate charge; typical values

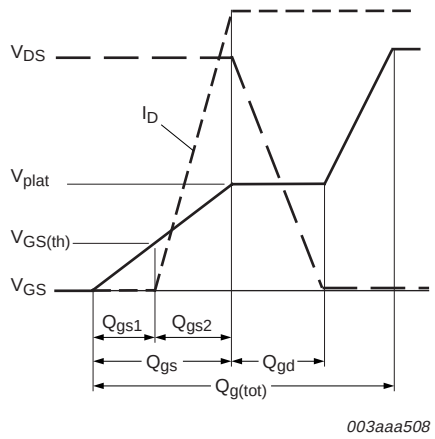
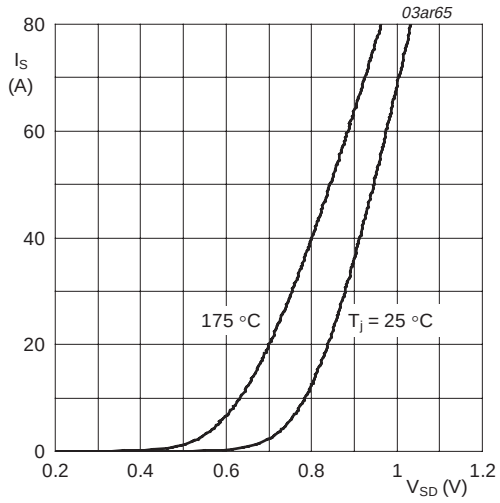
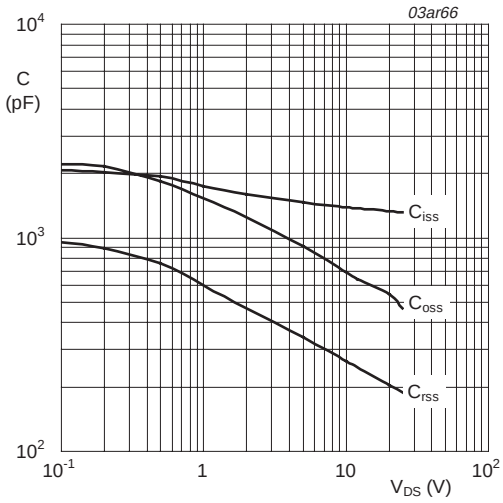


Fig 12. Gate charge waveform definitions



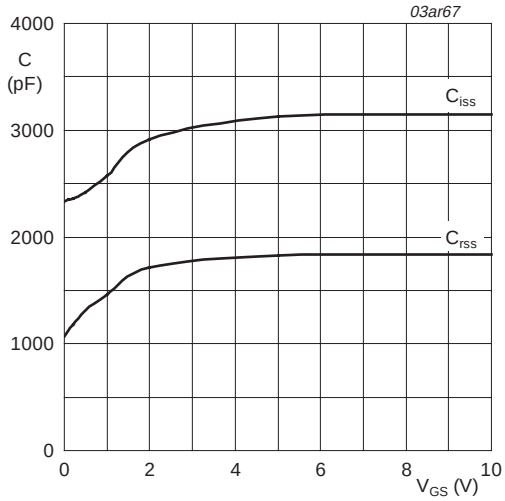
T_j = 25 °C and 175 °C; V_{GS} = 0 V

Fig 13. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values



V_{GS} = 0 V; f = 1 MHz

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

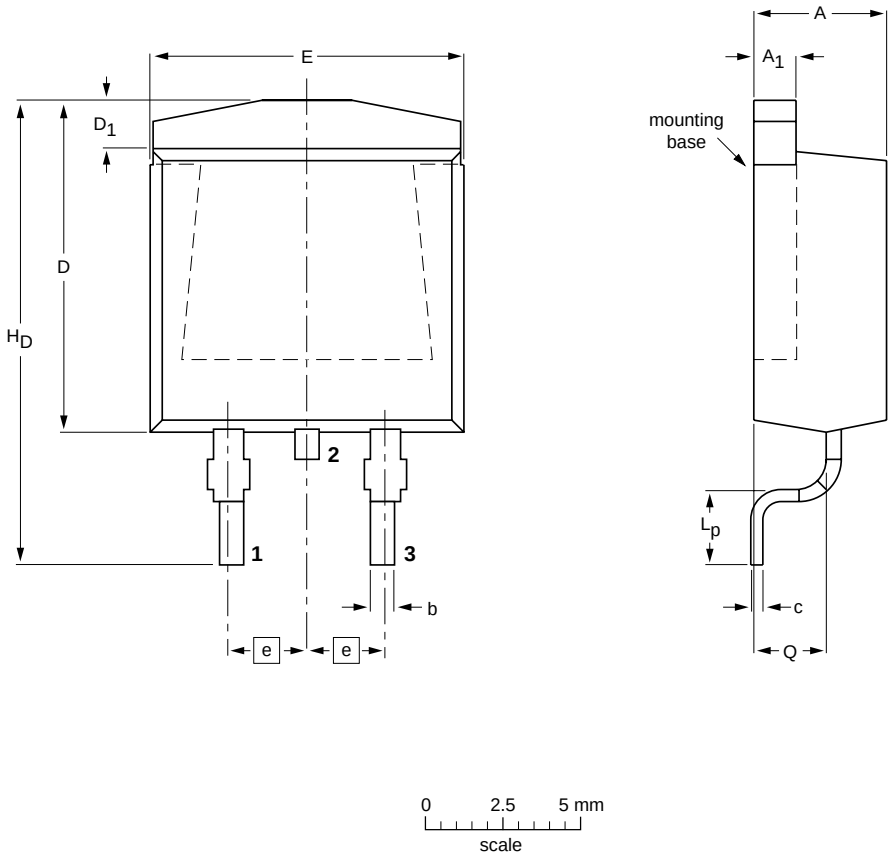


V_{DS} = 0 V

Fig 15. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

7. Package outline

Plastic single-ended surface mounted package (D2PAK); 3 leads (one lead cropped) **SOT404**



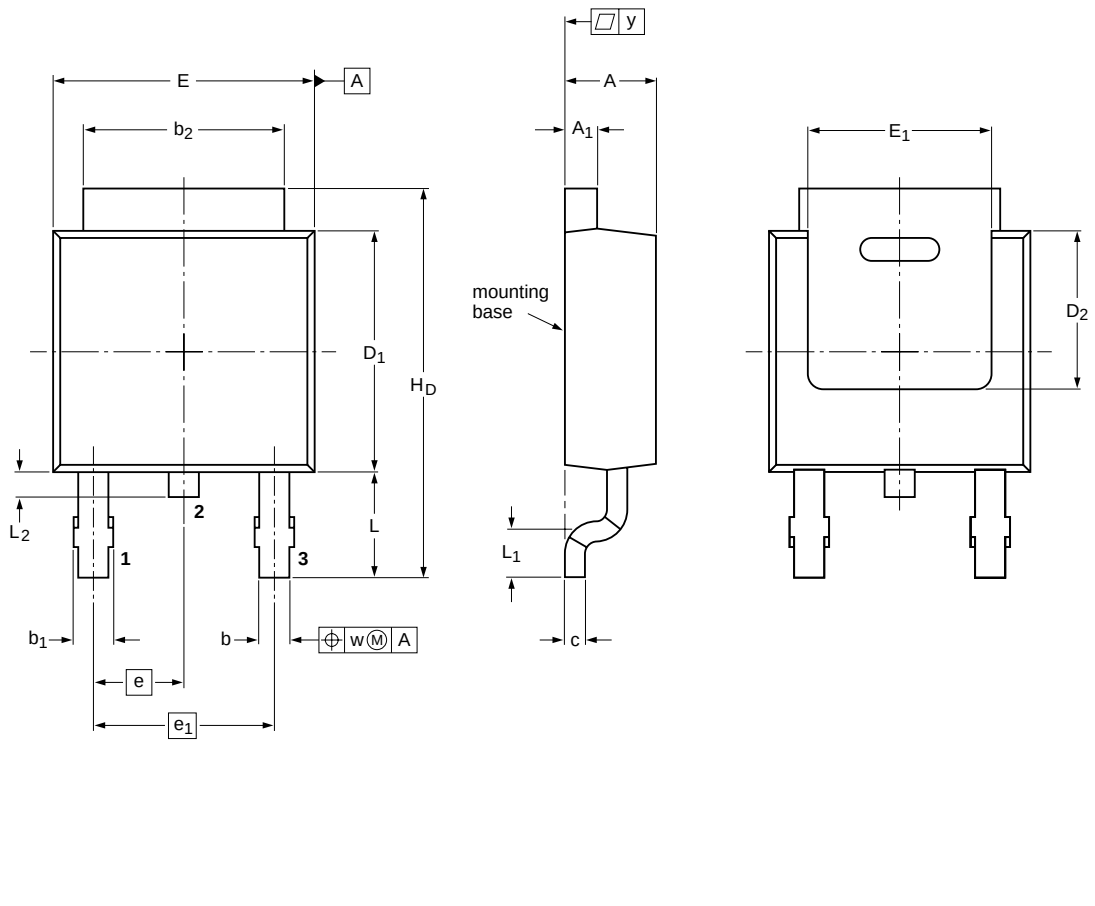
DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	c	D max.	D_1	E	e	L_p	H_D	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	2.54	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT404						~~04-10-13~~ 05-02-11

Fig 16. Package outline SOT404 (D2PAK)

Plastic single-ended surface mounted package (DPAK); 3 leads (one lead cropped) **SOT428**



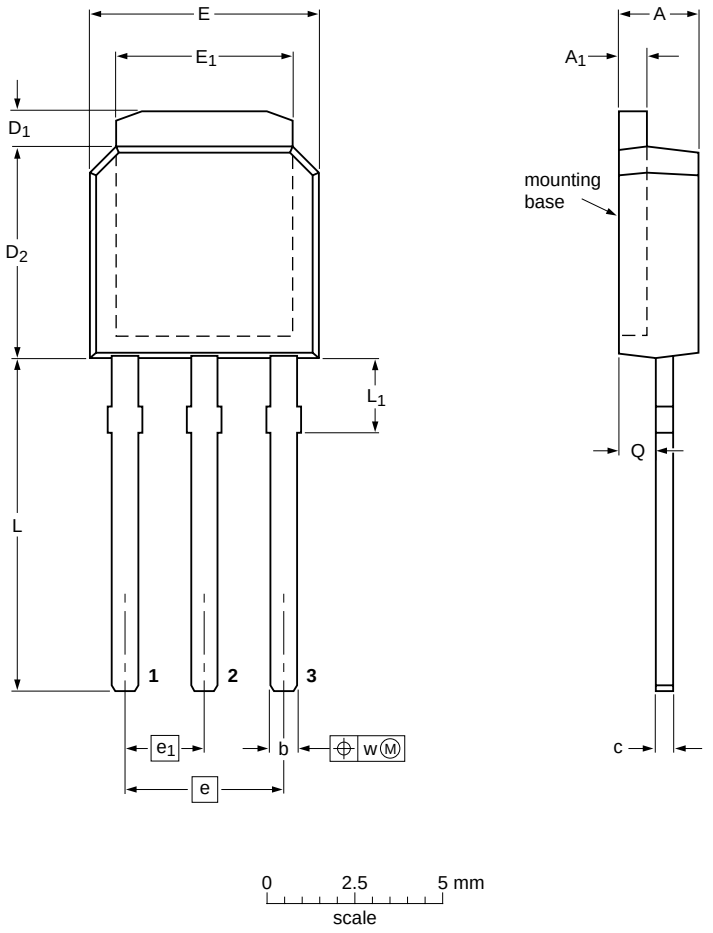
DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	b_1	b_2	c	D_1	D_2 min	E	E_1 min	e	e_1	H_D	L	L_1 min	L_2	w	y max
mm	2.38 2.22	0.93 0.73	0.89 0.71	1.1 0.9	5.46 5.00	0.56 0.20	6.22 5.98	4.0	6.73 6.47	4.45	2.285	4.57	10.4 9.6	2.95 2.55	0.5	0.9 0.5	0.2	0.2

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT428		TO-252	SC-63			~~05-02-09~~ 05-02-11

Fig 17. Package outline SOT428 (DPAK)

Plastic single-ended package (IPAK); 3 leads (in-line) **SOT533**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	c	D_1	D_2	E	E_1	e	e_1	L	L_1(2) max	Q	w
mm	2.38 2.22	0.89 0.71	0.89 0.71	0.56 0.46	1.10 0.96	6.23 5.97	6.73 6.47	5.21 5.00	4.57 BSC(1)	2.285 BSC(1)	9.6 9.2	2.7	1.1 1.0	0.3

Notes

1. Basic spacing between centers.
2. Terminal dimensions are uncontrolled within zone L_1.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT533		TO-251				~~04-09-22~~ 05-02-11

Fig 18. Package outline SOT533 (IPAK)

8. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PHB_PHD_PHU108NQ03LT_3	20050418	Product data sheet	2004070095	9397 750 14707	PHP_PHB_PHD108NQ03LT-02
Modifications:	• The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors. • Removal of PHP108NQ03LT • Addition of PHU108NQ03LT • Section 4 “Limiting values” I_D, I_{DM}, P_{tot} and I_{SM} data corrected. • Table 5 “Characteristics” R_{DSon}, $Q_{g(tot)}$, Q_{gs}, Q_{gd}, C_{iss}, C_{oss}, C_{rss}, $t_{d(on)}$, t_r, $t_{d(off)}$, t_f and Q_r test conditions and/or typical values modified. • Table 5 “Characteristics” R_G, Q_{gs1}, Q_{gs2} and V_{plat} tests added. • Table 5 “Characteristics” $V_{GS(th)}$, C_{iss}, C_{rss} and $Q_{g(tot)}$ data added. • Figure 2, 3, 4, 5, 6, 7, 8, 11,13 and 14 modified. • Figure 12 and 15 added.			
PHP_PHB_PHD108NQ03LT-02	20020911	Product data	-	9397 750 10159	PHP_PHB_PHD108NQ03LT-01
PHP_PHB_PHD108NQ03LT-01	20011218	Product data	-	9397 750 09065	-

9. Data sheet status

Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

10. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

11. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

12. Trademarks

TrenchMOS — is a trademark of Koninklijke Philips Electronics N.V.

13. Contact information

For additional information, please visit: **http://www.semiconductors.philips.com**

For sales office addresses, send an email to: **sales.addresses@www.semiconductors.philips.com**

14. Contents

1	**Product profile**	**1**
1.1	General description	1
1.2	Features	1
1.3	Applications	1
1.4	Quick reference data	1
2	**Pinning information**	**1**
3	**Ordering information**	**2**
4	**Limiting values**	**2**
5	**Thermal characteristics**	**4**
6	**Characteristics**	**5**
7	**Package outline**	**9**
8	**Revision history**	**12**
9	**Data sheet status**	**13**
10	**Definitions**	**13**
11	**Disclaimers**	**13**
12	**Trademarks**	**13**
13	**Contact information**	**13**

Date of release: 18 April 2005
Document number: 9397 750 14707

Published in The Netherlands